Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10584790	MIYAKE ET AL.
Examiner	Art Unit
Lana N Le	2614

SEARCHED						
Class	Subclass	Date	Examiner			
455	150.1,180.1,307	9/02/09	LL			

SEARCH NOTES				
	Search Notes	Date	Examiner	
	INTERFERENCE SEAF	RCH		
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20090902